

## HIGH-SPEED OPTICAL WAVELENGTH METER 828 Series

## The fastest wavelength measurement available for WDM testing applications.

Bristol Instruments, the leader in optical wavelength measurement instrumentation, offers an interferometer-based wavelength meter that is designed to revolutionize WDM testing applications. The 828 Optical Wavelength Meter employs a unique Fizeau etalon design that results in the ability to measure wavelength to an accuracy as high as  $\pm$  0.3 pm at an unmatched measurement rate of 1 kHz. This enables greater efficiency in the production of WDM components by reducing test times from hours to minutes. What's more, a time resolution of 1 ms results in the most detailed wavelength characterization of tunable lasers.



## **KEY FEATURES**

- Wavelength measured to an accuracy as high as  $\pm$  0.3 pm.
- Automatic calibration with a built-in wavelength standard.
- Measurement confidence level of  $\geq$  99.7%.
- Traceable to NIST standard.
- Simultaneous measurement of optical power to  $\pm$  0.5 dB.
- High sensitivity of -40 dBm (0.1  $\mu$ W).
- Operates with CW and modulated signals.

- Fastest measurement rate of 1 kHz for reduced testing times.
- Time resolution of 1 ms for the most detailed wavelength characterization.
- Convenient touch-screen display reports measurement data in a variety of formats.
- Interfacing via SCPI using USB, Ethernet, or GPIB.
- Data streaming available using RS-422 serial interface.
- Internal data storage for up to one million measurements.
- Rugged design for manufacturing environments.

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## It's Our Business to be Exact!

SPECIFICATIONS			828 Series	
MO	DEL	828A	828B	
OPTICAL SIGNAL		CW and modulated		
WAVELENGTH				
	Range	1250 – 1650 nm	(182 – 240 THz)	
	Accuracy <sup>1, 2</sup>	$\pm$ 0.2 parts per million ( $\pm$ 0.3 pm at 1550 nm)	± 0.65 parts per million (± 1 pm at 1550 nm)	
	Repeatability <sup>3, 4</sup>	$\pm$ 0.02 parts per million ( $\pm$ 0.03 pm at 1550 nm)	$\pm$ 0.07 parts per million (± 0.1 pm at 1550 nm)	
	Calibration <sup>5</sup>	Automatic with built-in	wavelength standard	
	Display Resolution	0.00001 nm	0.0001 nm	
	Units 6	nm, cm	r-1, THz	
POWER				
	Calibration Accuracy	± 0.5 dB (± 30 nm fro	m 1310 and 1550 nm)	
	Linearity <sup>4</sup>	± 0.5 dB (1250 – 1600 nm)		
	Polarization Dependence	± 0.5 dB (1250	0 – 1600 nm)	
	Display Resolution	0.01 dB		
	Units	dBm, mW		
OPI	ICAL INPUT SIGNAL			
	Maximum Laser Bandwidth 7	1 GHz (8 pm at 1550 nm)	10 GHz (80 pm at 1550 nm)	
	Sensitivity <sup>8</sup>	1 kHz: -20 dBm (10 μW) 500 Hz: -25 dBm (3 μW) 250 Hz: -29 dBm (1.25 μW) 100 Hz: -33 dBm (0.5 μW)	1 kHz: -25 dBm (3 μW) 500 Hz: -30 dBm (1 μW) 250 Hz: -35 dBm (0.3 μW) 100 Hz: -40 dBm (0.1 μW)	
	Maxiumum Power Displayed level Safe level	+ 10 dBm + 18 dBm	(10 mW) (63 mW)	
	Return Loss <sup>4</sup>	35 (	dB	
MEASUREMENT RATE/TIME <sup>9</sup>		1 kHz streaming over RS-422 serial interface 5 ms (SCPI commands)		
INPUTS/OUTPUTS				
	Optical Input	9/125 µm single-mode fib	per (FC/UPC or FC/APC)	
	Instrument Interface	Streaming via RS-422 (inter Library of commands (SCPI) via US Internal data storage for up f	rnal or external TTL trigger) 68 2.0, Ethernet, GPIB (optional) to 1 million measurements	
ENVIRONMENTAL 4				
Warm-Up Time		< 15 minutes		
	Temperature	+15°C to +30°C (-10°C to +70°C storage)		
	Pressure	500 - 900 mm Hg		
	Humidity	≤ 90% R.H. at +40°C (no condensation)		
DIMENSIONS AND WEIGHT				
	Dimensions (H x W x D)	3.5" x 17.0" x 15.0" (89 m	ım x 432 mm x 381 mm)	
	Weight	17 lbs (7.7 kg)	16 lbs (7.2 kg)	
PO	VER REQUIREMENTS	90 - 264 VAC, 47	- 63 Hz, 50 VA max	
WARRANTY		5 years		
<ol> <li>Determinant</li> <li>Training</li> <li>Traini</li></ol>	<ul> <li>1) Defined as measurement uncertainty, or maximum wavelength error, with a confidence level of ≥ 99.7%.</li> <li>2) Traceable to NIST standard (SRM 2517a).</li> <li>3) Standard deviation for a 10 minute measurement period.</li> <li>4) Characteristic performance, but non-warranted.</li> <li>5) Laser diode locked to acetylene absorption (NIST Special Publication 260-133).</li> <li>6) Data in units of nm and cm-1 are given as vacuum values.</li> <li>7) Bandwidth is FWHM.</li> <li>8) Dependent on frame rate of the photodetector array.</li> <li>9) Measurement time using SCPL commands dependent on PC/network timing.</li> </ul>			

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Bristol Instruments reserves the right to change the detail specifications as may be required to permit improvements in the design of its products. Specifications are subject to change without notice.